

# MOSFET – Power, Single N-Channel, SO8FL 40 V, 3.1 m $\Omega$ , 83 A

## NTMFS3D1N04XM

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Small Footprint (5 x 6 mm) with Compact Design
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Applications**

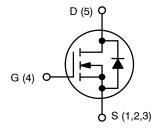
- Motor Drive
- Battery Protection
- Oring

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage DC			$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	83	Α
Current	Steady State	T <sub>C</sub> = 100°C		58	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	39	W
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	25	Α
Current R <sub>θJA</sub>	State	T <sub>A</sub> = 100°C		18	
Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \ \mu s$			I <sub>DM</sub>	506	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			Is	55	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 4.6 A)			E <sub>AS</sub>	133	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

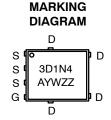
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	3.1 m $\Omega$ @ 10 V	83 A



**N-CHANNEL MOSFET** 





3D1N4 = Specific Device code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter		Value	Unit
Thermal Resistance, Junction-to-Case (Note 2)		3.79	°C/W
Thermal Resistance, Junction-to-Ambient (Notes 1, 2)		41.6	

## **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

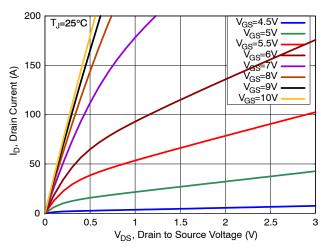
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	_					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 25^{\circ}\text{C}$	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/ \Delta T_J$	I <sub>D</sub> = 1 mA, Referenced to 25°C		15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 40 V, T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 25^{\circ}\text{C}$		2.7	3.1	mΩ
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 40 \mu A$ , $T_J = 25^{\circ} C$	2.5		3.5	V
Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(TH)}/ \Delta T_J$	$V_{GS} = V_{DS}$ , $I_D = 40 \mu A$		-7.2		mV/°C
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 20 A		79.6		S
CHARGES & CAPACITANCES				-		
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1002		pF
Output Capacitance	C <sub>OSS</sub>			717		1
Reverse Transfer Capacitance	C <sub>RSS</sub>			18.4		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 50 A, V <sub>GS</sub> = 10 V		15.6		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			2.94		
Gate-to-Source Charge	$Q_{GS}$			4.82		1
Gate-to-Drain Charge	$Q_{GD}$			2.84		1
Gate Resistance	R <sub>G</sub>	f = 1 MHz		2.37		Ω
SWITCHING CHARACTERISTICS (Note 3)						
Turn-On Delay Time	t <sub>d(ON)</sub>	Resistive Load, V <sub>GS</sub> = 0/10 V,		13.8		ns
Rise Time	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, I_{D} = 50 \text{ A}, R_{G} = 0 \Omega$		4.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>			18.8		
Fall Time	t <sub>f</sub>			4.15		1
DRAIN-SOURCE DIODE CHARACTERIST	ics					
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V, } I_S = 20 \text{ A, } T_J = 25^{\circ}\text{C}$		0.82	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A, T <sub>J</sub> = 125°C		0.67		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } I_{S} = 50 \text{ A,}$		29		ns
Charge Time	ta	di/dt = 100 A/μs, V <sub>DD</sub> = 20 V		11.3		ns
Discharge Time	t <sub>b</sub>	[		17.8		ns
Reverse Recovery Time	Q <sub>RR</sub>			14.5		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

Surface-mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz Cu pad.
 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

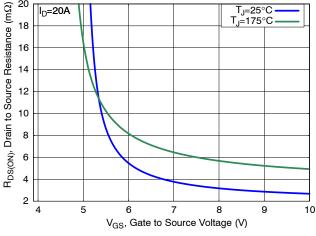
## **TYPICAL CHARACTERISTICS**



200 180 160 (4) 140 120 100 80 20 40 20 1 = 25°C T<sub>j</sub>=25°C T<sub>j</sub>=175°C V<sub>GS</sub>, Gate to Source Voltage (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



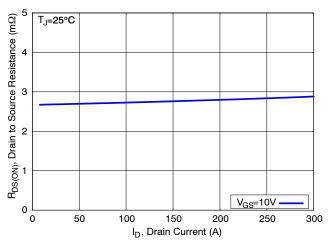
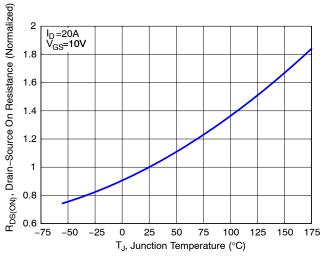


Figure 3. On-Resistance vs. Gate Voltage

Figure 4. On-Resistance vs. Drain Current



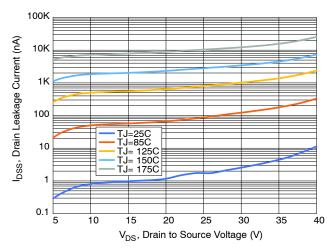


Figure 5. Normalized ON Resistance vs. Junction Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

## **TYPICAL CHARACTERISTICS**

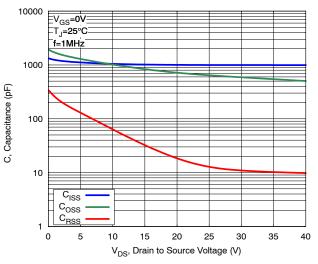


Figure 7. Capacitance Characteristics

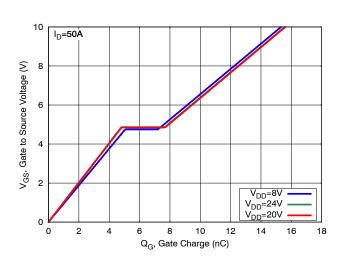


Figure 8. Gate Charge Characteristics

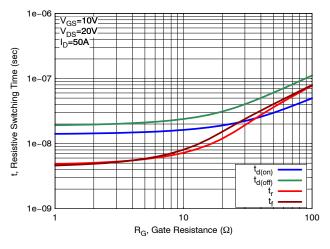


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

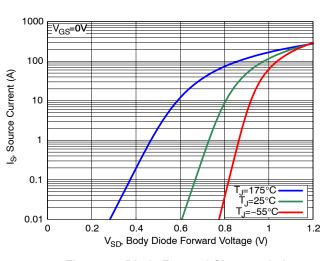


Figure 10. Diode Forward Characteristics

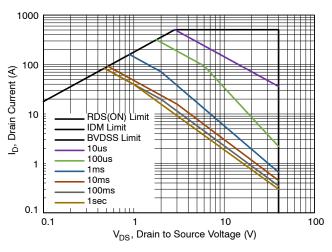


Figure 11. Safe Operating Area (SOA)

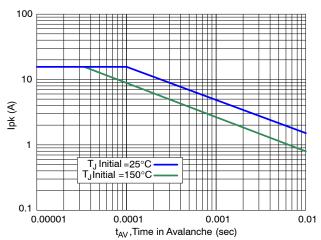


Figure 12. Ipeak vs. Time in Avalanche

## **TYPICAL CHARACTERISTICS**

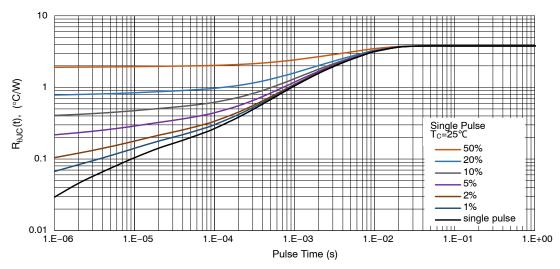


Figure 13. Transient Thermal Response

## **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMFS3D1N04XMT1G	3D1N4	DFN5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



0.10

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

## **DATE 25 JUN 2018**

#### NOTES:

BURRS.

M

3.00

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION DI AND E1 DO NOT INCLUDE
  MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			

## **GENERIC** MARKING DIAGRAM\*

3.40

3.80

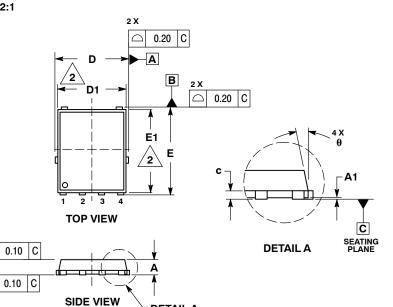


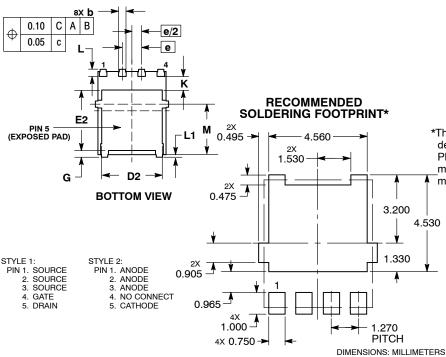
XXXXXX = Specific Device Code = Assembly Location Α

= Year

W = Work Week ΖZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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